Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination YONEDA, KENJI | Examiner | Art Unit | Jean F. Duverne | 2839 | Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| | Α | US-4,310,209 | 01-1982 | Fleming et al. | 439/99 |
| | В | US-5,440,665 A | 08-1995 | Ray et al. | 385/135 |
| | С | US-4,724,024 | 02-1988 | Van Der Velde et al. | 156/181 |
| | D | U.S= | | | |
| | Ε | US-6,507,693 B2 | 01-2003 | Maron et al. | 385/137 |
| | F | US- | | | |
| | G | US- | | | |
| | Н | US- | | | |
| | 1 | US- | | | |
| | J | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | · | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | w | |
| | x | |

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